


<b>Search Notes</b>  	<b>Application/Control No.</b>  10542358	<b>Applicant(s)/Patent Under Reexamination</b>  YOKOYAMA ET AL.
	<b>Examiner</b>  Mark L Shevin	<b>Art Unit</b>  1793

### SEARCHED

Class	Subclass	Date	Examiner
423	324-350	03/04/2008	MLS
427	344,372.2,383.3,383.7,384,387,388.1,397.7 and class-wide text search	03/04/2008	MLS
252	62.3R-62.3C, 500-521.6 and class-wide text search	03/04/2008	MLS

### SEARCH NOTES

Search Notes	Date	Examiner
Inventor name search (eDan, EAST, Google Scholar)	03/04/2008	MLS
Assignee name search "JSR"	03/04/2008	MLS
Derwent: L03-E05B , M13-B , U11-C05C6 , U11-C05C7	03/04/2008	MLS
IPC: C23C 18/ , C22C 21/ , C03C 17/ , H01B 5/ , H01L 31/	03/04/2008	MLS
IFWs for cases: 09/948,572 , 09/701,534 , 11/787,445	03/04/2008	MLS
Search reports: PCT/JP2004/015101 , EP 04007238	03/04/2008	MLS
NPL: Scirus and Google Scholar for Al-Si electrodes and amine alane complexes	03/04/2008	MLS

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner